

# *Notice of References Cited*

Application/Control No.

10/691,119

Applicant(s)/Patent Under  
Reexamination  
SEWARD ET AL.

Examiner

CATHERINE N. WITCZAK

Art Unit

3767

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## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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